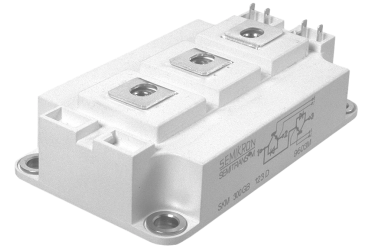


Absolute Maximum Ratings		Values	Units
Symbol	Conditions ¹⁾		
V_{CES}		1700	V
V_{CGR}	$R_{GE} = 20 \text{ k}\Omega$	1700	V
$I_C; I_{CN}$	$T_{case} = 25/80 \text{ }^\circ\text{C}$	320 / 230	A
I_{CM}	$T_{case} = 25/80 \text{ }^\circ\text{C}; t_p = 1 \text{ ms}$	640 / 460	A
V_{GES}		± 20	V
P_{tot}	per IGBT, $T_{case} = 25 \text{ }^\circ\text{C}$	1800	W
$T_j, (T_{stg})$		-40 ... +150 (125)	$^\circ\text{C}$
V_{isol}	AC, 1 min. ⁴⁾	3400	V
humidity	IEC 60721-3-3	class 3K7/IE32	
climate	IEC 68 T.1	40/125/56	
Inverse Diode ⁸⁾			
$I_F = -I_C$	$T_{case} = 25/80 \text{ }^\circ\text{C}$	390 / 260	A
$I_{FM} = -I_{CM}$	$T_{case} = 25/80 \text{ }^\circ\text{C}; t_p = 1 \text{ ms}$	640 / 460	A
I_{FSM}	$t_p = 10 \text{ ms}; \text{sin.}; T_j = 150 \text{ }^\circ\text{C}$	2200	A
I^2t	$t_p = 10 \text{ ms}; T_j = 150 \text{ }^\circ\text{C}$	24200	A^2s

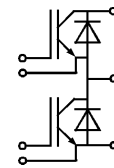
Characteristics		min.	typ.	max.	Units
Symbol	Conditions ¹⁾				
$V_{(BR)CES}$	$V_{GE} = 0, I_C = 6 \text{ mA}$	$\geq V_{CES}$	-	-	V
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 9 \text{ mA}$	4,5	5,5	6,5	V
I_{CES}	$V_{GE} = 0 \left. \begin{array}{l} T_j = 25 \text{ }^\circ\text{C} \\ T_j = 125 \text{ }^\circ\text{C} \end{array} \right\}$	-	0,1	1	mA
		-	8	-	mA
I_{GES}	$V_{GE} = 20 \text{ V}, V_{CE} = 0$	-	-	0,2	μA
V_{CESat}	$I_C = 200 \text{ A} \left. \begin{array}{l} V_{GE} = 15 \text{ V}; \\ T_j = 25 (125) \text{ }^\circ\text{C} \end{array} \right\}$	-	2,8(3,25)	3,3(3,8)	V
		-	3,3(3,8)	-	V
g_{fs}	$V_{CE} = 20 \text{ V}, I_C = 200 \text{ A}$	80	110	-	S
C_{CHC}	per IGBT	-	-	0,7	nF
C_{ies}	$V_{GE} = 0$	-	14	-	nF
C_{oes}	$V_{CE} = 25 \text{ V}$	-	2,0	-	nF
C_{res}	$f = 1 \text{ MHz}$	-	0,6	-	nF
L_{CE}		-	-	20	nH
$t_{d(on)}$	$V_{CC} = 1200 \text{ V}$	-	100	-	ns
t_r	$V_{GE} = -15 \text{ V} / +15 \text{ V} \text{ } ^3)$	-	100	-	ns
$t_{d(off)}$	$I_C = 200 \text{ A}, \text{ind. load}$	-	900	-	ns
t_f	$R_{Gon} = R_{Goff} = 6,8 \text{ } \Omega$	-	150	-	ns
E_{on}	$T_j = 125 \text{ }^\circ\text{C} (V_{CC} = 900 \text{ V}/1200 \text{ V})$	-	90/125	-	mWs
E_{off}	$L_S = 60 \text{ nH} (V_{CC} = 900 \text{ V}/1200 \text{ V})$	-	65/95	-	mWs
Inverse Diode ⁸⁾					
$V_F = V_{EC}$	$I_F = 200 \text{ A} \left. \begin{array}{l} V_{GE} = 0 \text{ V}; \\ T_j = 25 (125) \text{ }^\circ\text{C} \end{array} \right\}$	-	2,15(1,9)	2,4(2,25)	V
$V_F = V_{EC}$		$I_F = 300 \text{ A}$	-	2,4(2,2)	2,75(2,5)
V_{TO}	$T_j = 125 \text{ }^\circ\text{C}$	-	1,3	1,5	V
r_t	$T_j = 125 \text{ }^\circ\text{C}$	-	3	4	$\text{m}\Omega$
I_{RRM}	$I_F = 200 \text{ A}; T_j = 25 (125) \text{ }^\circ\text{C} \text{ } ^2)$	-	100(200)	-	A
Q_{rr}	$I_F = 200 \text{ A}; T_j = 25 (125) \text{ }^\circ\text{C} \text{ } ^2)$	-	24(50)	-	μC
E_{rr}	$I_F = 200 \text{ A}; T_j = 25 (125) \text{ }^\circ\text{C} \text{ } ^2)$	-	10(18)	-	mWs
Thermal characteristics					
R_{thjc}	per IGBT	-	-	0,07	$^\circ\text{C}/\text{W}$
R_{thjc}	per diode D	-	-	0,125	$^\circ\text{C}/\text{W}$
R_{thch}	per module (50 μm grease)	-	-	0,038	$^\circ\text{C}/\text{W}$

SEMITRANS® M Low Loss IGBT Modules

SKM 300 GB 174 D



SEMITRANS 3



GB

Features

- N channel, homogeneous Silicon structure (NPT- Non punch-through IGBT)
- Low inductance case
- High short circuit capability, self limiting
- Fast & soft inverse CAL diodes ⁸⁾
- Without hard mould
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (13 mm) and creepage distances (20 mm)

Typical Applications

- AC inverter drives on mains 575 - 750 V_{AC}
- DC bus voltage 750 - 1200 V_{DC}
- Public transport (auxiliary syst.)
- Switching (not for linear use)

¹⁾ $T_{case} = 25 \text{ }^\circ\text{C}$, unless otherwise specified

²⁾ $I_F = -I_C, V_R = 1200 \text{ V}, -di_F/dt = 2000 \text{ A}/\mu\text{s}, V_{GE} = 0 \text{ V}$

³⁾ Use $V_{GEOff} = -5 \dots -15 \text{ V}$

⁴⁾ Option $V_{isol} = 4000\text{V}/1 \text{ min}$ add suffix „H4“ - on request

⁸⁾ CAL = Controlled Axial Lifetime Technology

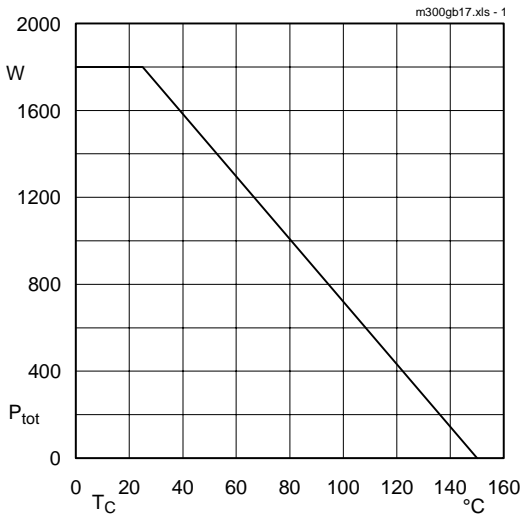


Fig. 1 Rated power dissipation $P_{tot} = f(T_C)$

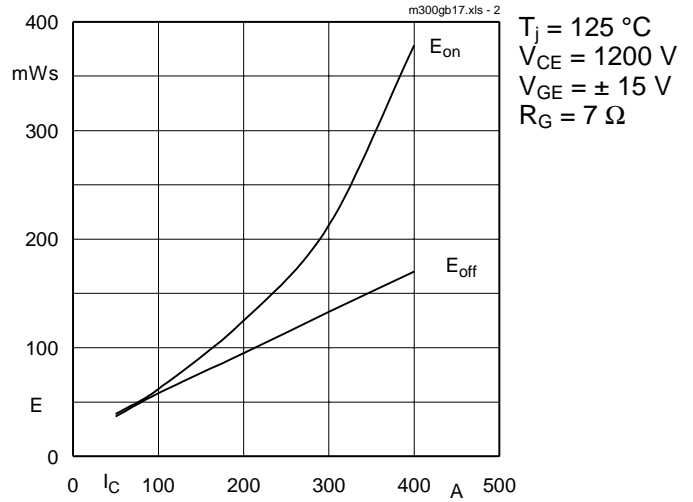


Fig. 2 Turn-on /-off energy $= f(I_C)$

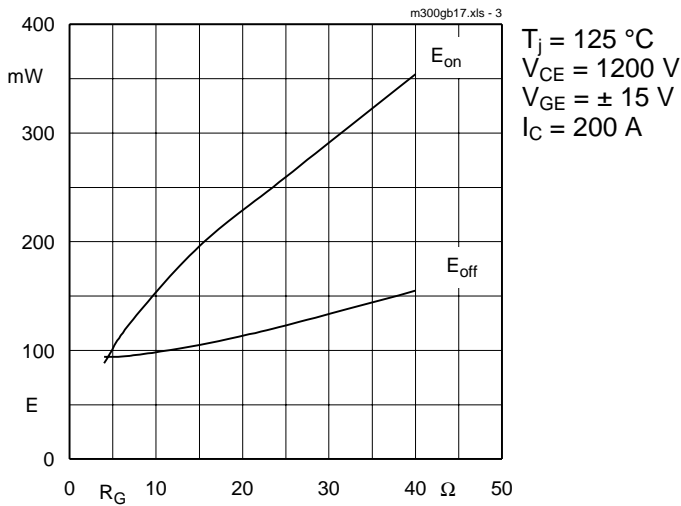


Fig. 3 Turn-on /-off energy $= f(R_G)$

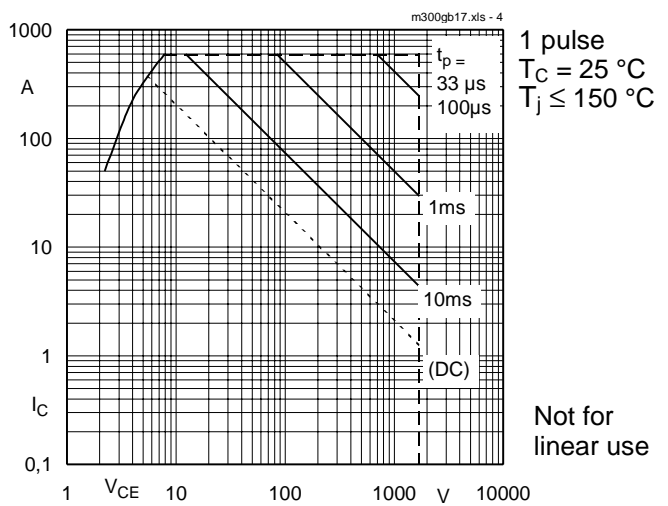


Fig. 4 Maximum safe operating area (SOA) $I_C = f(V_{CE})$

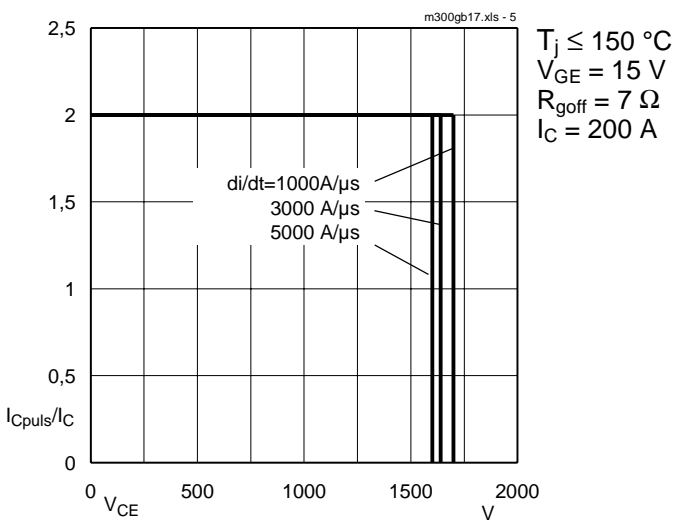


Fig. 5 Turn-off safe operating area (RBSOA)

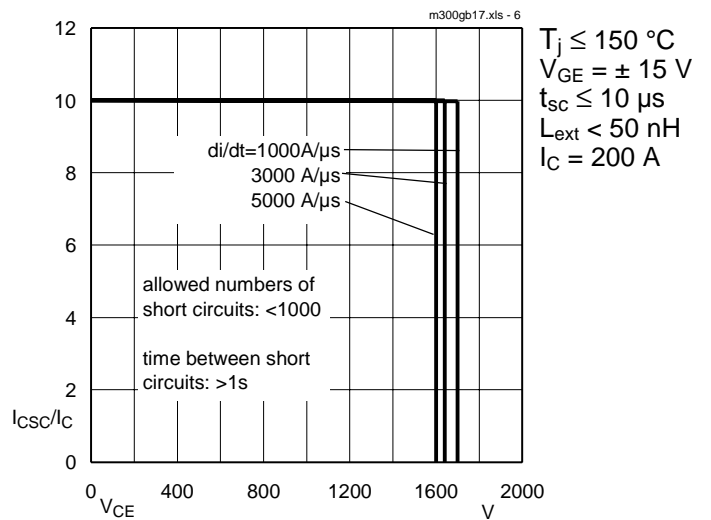


Fig. 6 Safe operating area at short circuit $I_C = f(V_{CE})$

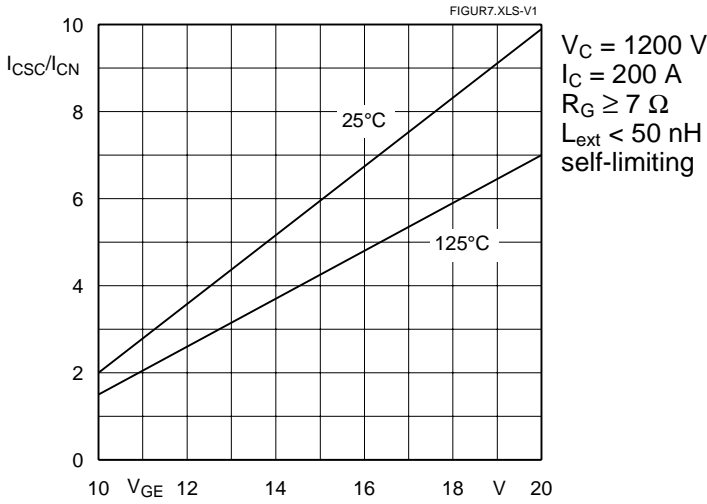


Fig. 7 Short circuit current vs. turn-on gate voltage

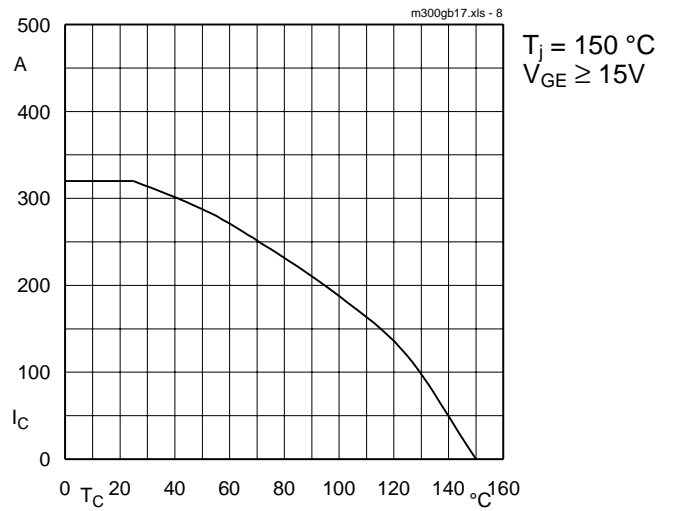


Fig. 8 Rated current vs. temperature $I_C = f(T_C)$

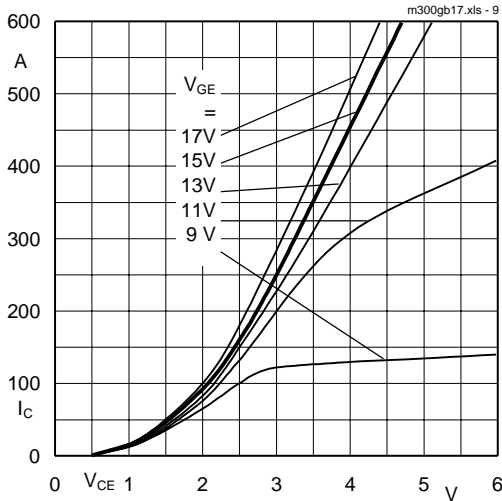


Fig. 9 Typ. output characteristic, $t_p = 250 \mu s$; $T_j = 25 \text{ }^\circ\text{C}$

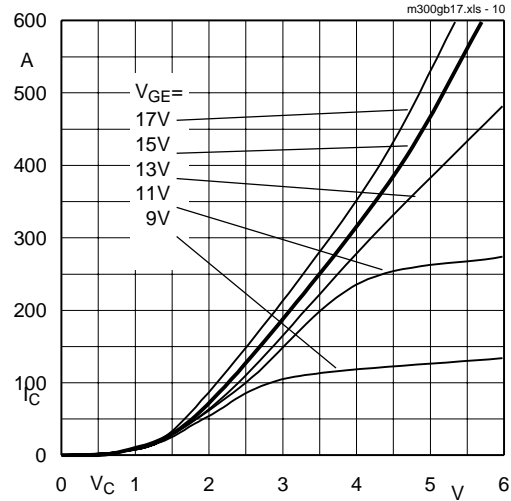


Fig. 10 Typ. output characteristic, $t_p = 250 \mu s$; $T_j = 125 \text{ }^\circ\text{C}$

$$P_{cond(t)} = V_{CEsat(t)} \cdot I_{C(t)}$$

$$V_{CEsat(t)} = V_{CE(TO)(T_j)} + r_{CE(T_j)} \cdot I_{C(t)}$$

$$V_{CE(TO)(T_j)} \leq 1,5 + 0,001 (T_j - 25) \text{ [V]}$$

$$\text{typ: } r_{CE(T_j)} = 0,0065 + 0,000018 (T_j - 25) \text{ [\Omega]}$$

$$\text{max: } r_{CE(T_j)} \leq 0,0088 + 0,000023 (T_j - 25) \text{ [\Omega]}$$

$$\text{valid for } V_{GE} \leq +15 \frac{+2}{-1} \text{ [V]; } I_C \geq 0,3 I_{Cnom}$$

Fig. 11 Typ. saturation characteristic (IGBT)
Calculation elements and equations

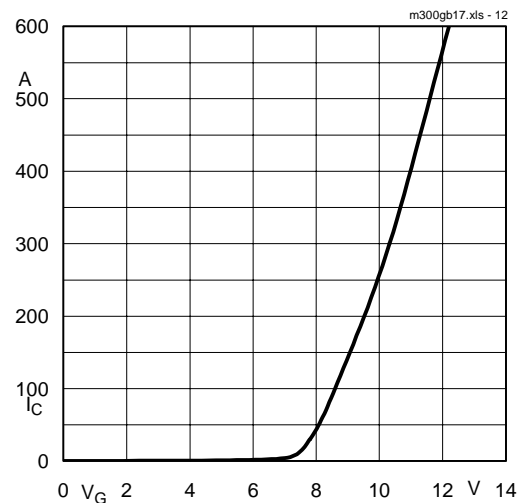


Fig. 12 Typ. transfer characteristic, $t_p = 250 \mu s$; $V_{CE} = 20 \text{ V}$

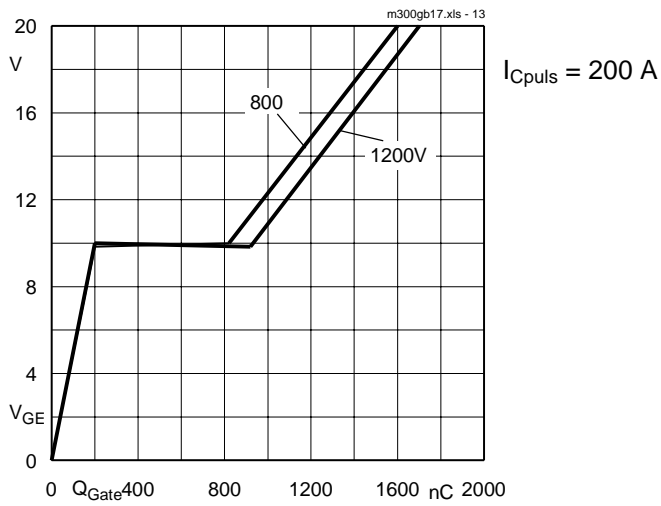


Fig. 13 Typ. gate charge characteristic

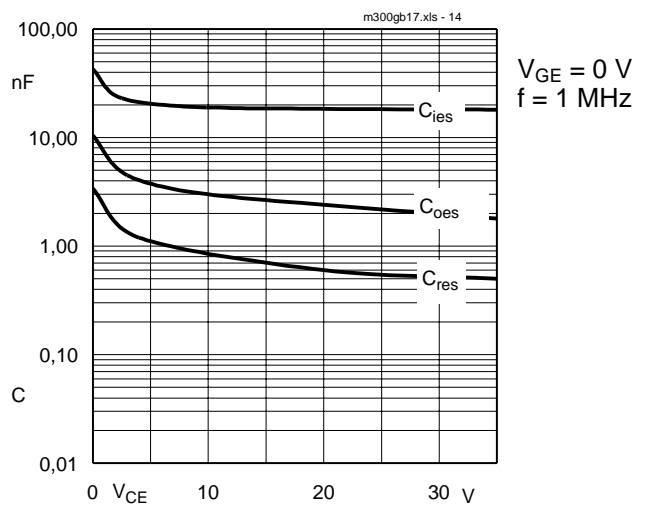


Fig. 14 Typ. capacitances vs. V_{CE}

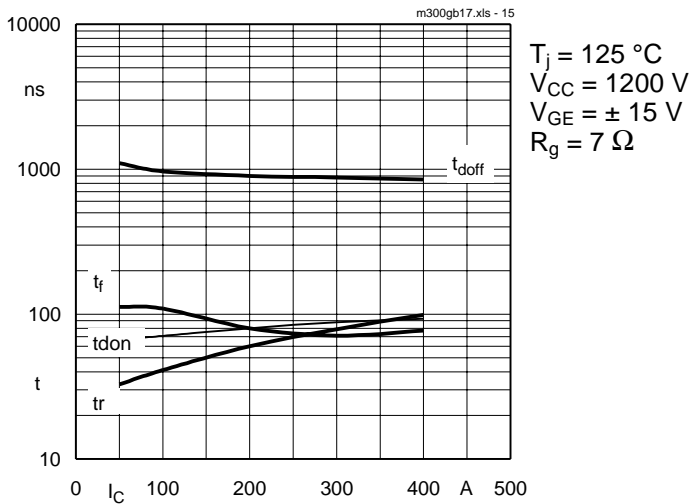


Fig. 15 Typ. switching times vs. I_C

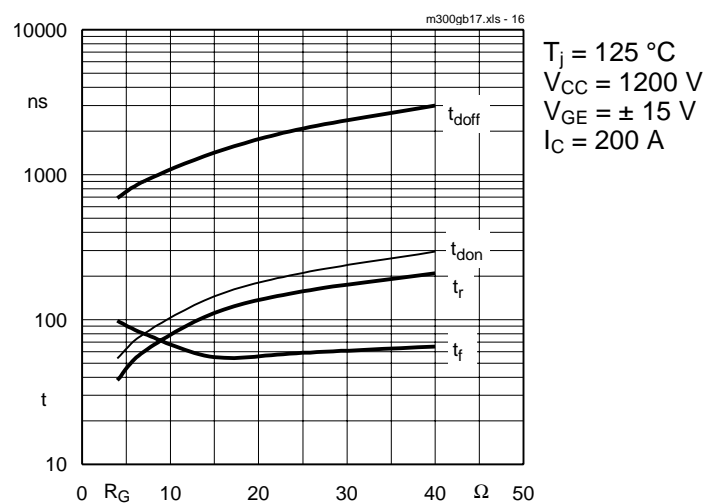


Fig. 16 Typ. switching times vs. gate resistor R_G

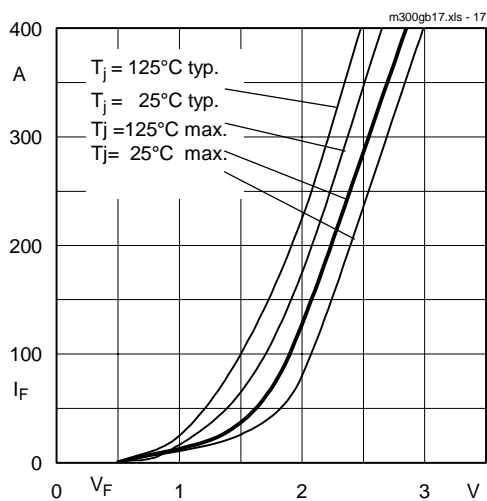


Fig. 17 Typ. CAL diode forward characteristic

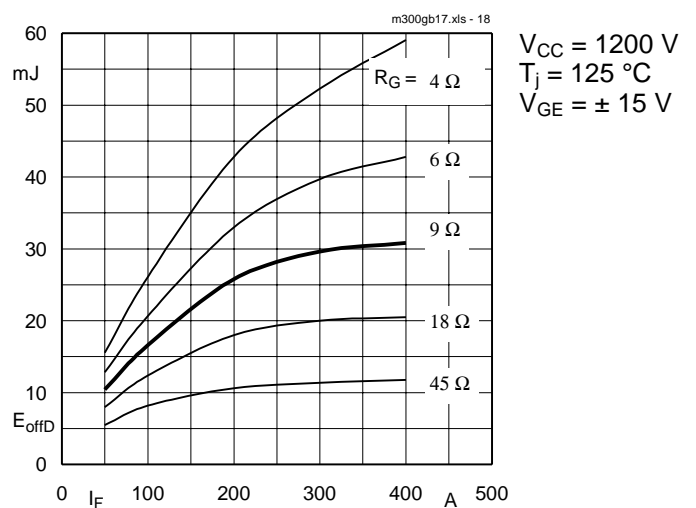


Fig. 18 Diode turn-off energy dissipation per pulse

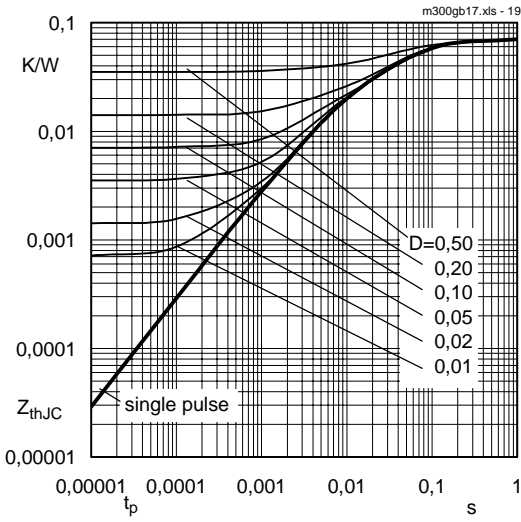


Fig. 19 Transient thermal impedance of IGBT
 $Z_{thJC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

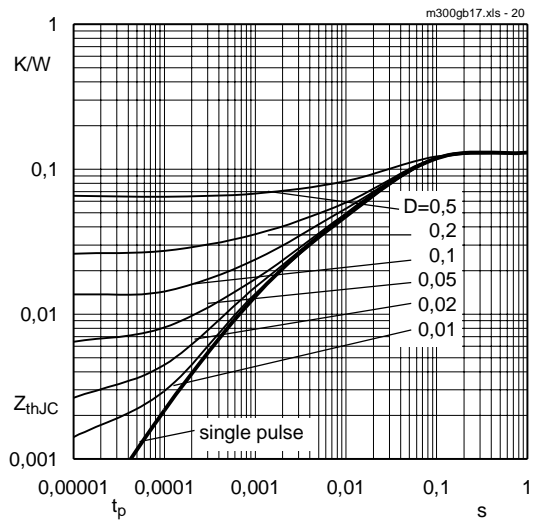


Fig. 20 Transient thermal impedance of inverse CAL diodes
 $Z_{thJC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

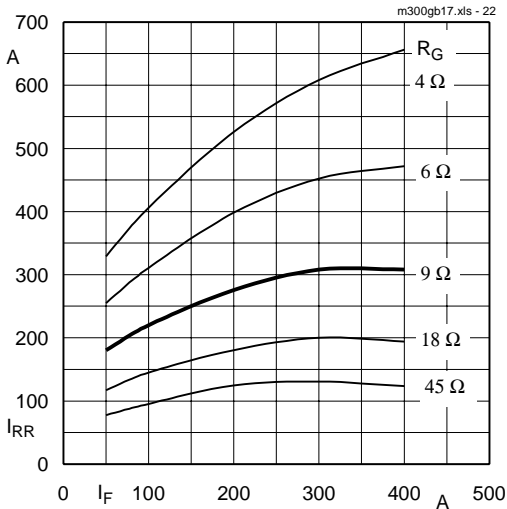


Fig. 22 Typ. CAL diode peak reverse recovery current $I_{RR} = f(I_F; R_G)$

$V_{CC} = 1200\text{ V}$
 $T_j = 125\text{ }^\circ\text{C}$
 $V_{GE} = \pm 15\text{ V}$

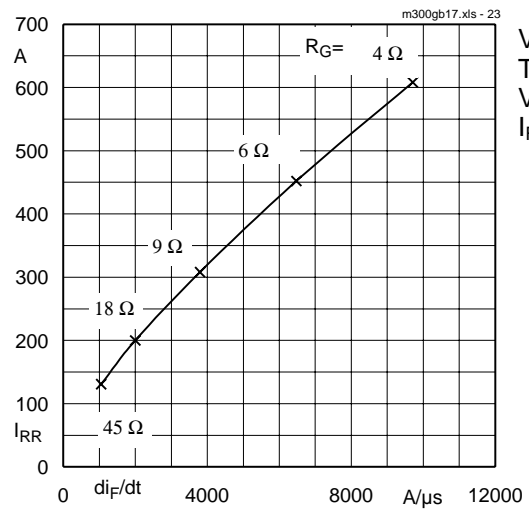


Fig. 23 Typ. CAL diode peak reverse recovery current $I_{RR} = f(di/dt)$

$V_{CC} = 1200\text{ V}$
 $T_j = 125\text{ }^\circ\text{C}$
 $V_{GE} = \pm 15\text{ V}$
 $I_F = 200\text{ A}$

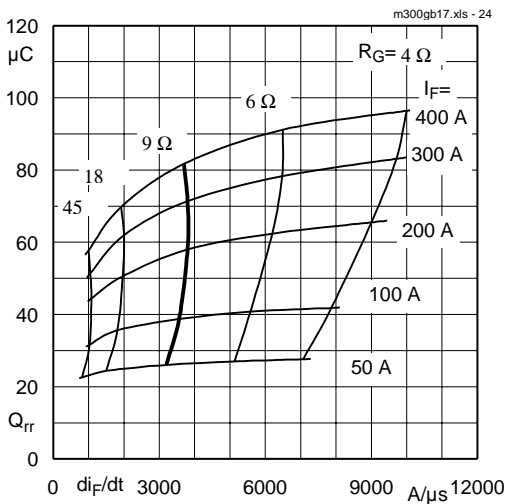
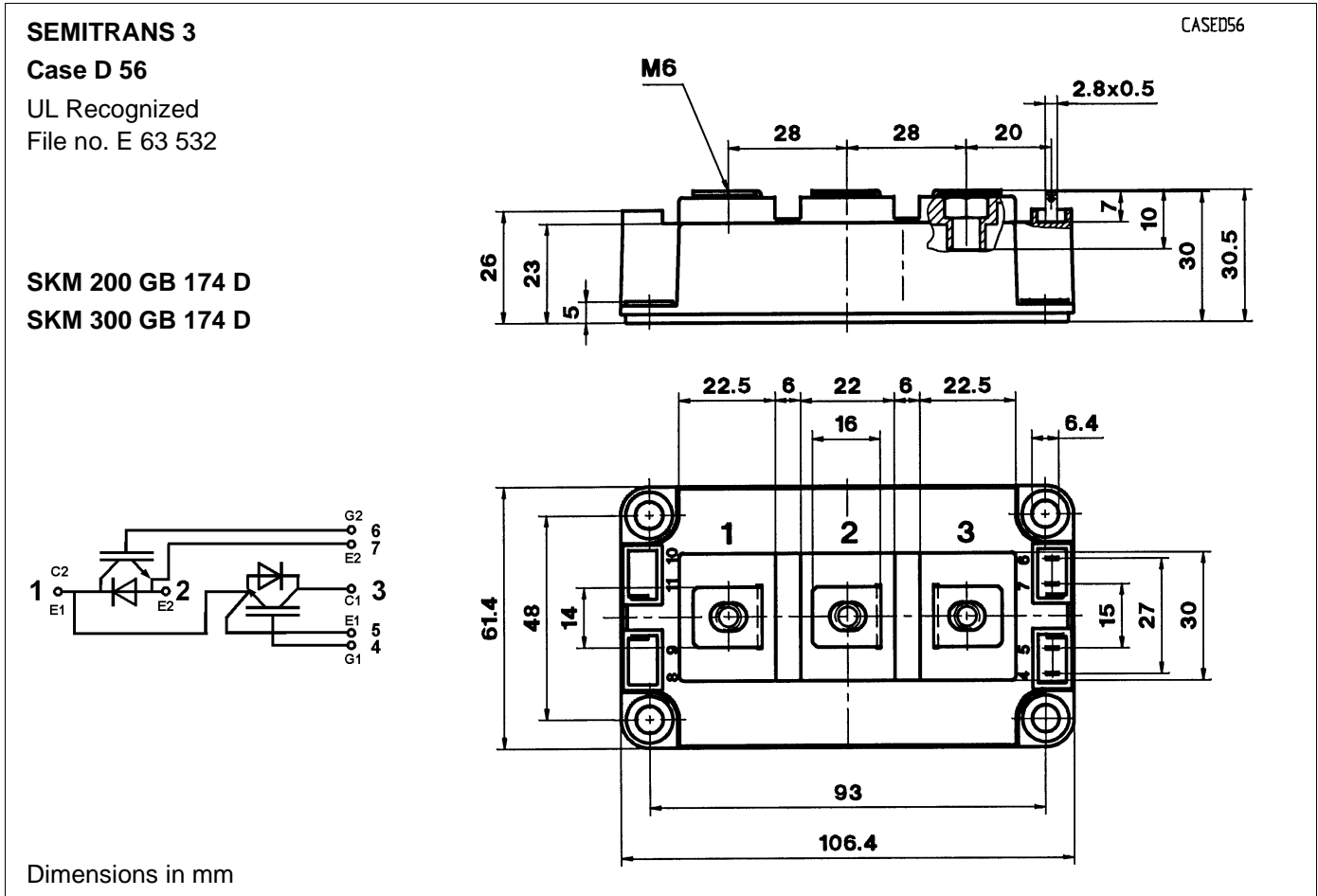


Fig. 24 Typ. CAL diode recovered charge

$V_{CC} = 1200\text{ V}$
 $T_j = 125\text{ }^\circ\text{C}$
 $V_{GE} = \pm 15\text{ V}$



Case outline and circuit diagram

Mechanical Data		Values			Units
Symbol	Conditions	min.	typ.	max.	
M ₁	to heatsink, SI Units	3	–	5	Nm
	to heatsink, US Units	27	–	44	lb.in.
M ₂	for terminals, SI Units	2,5	–	5	Nm
	for terminals, US Units	22	–	44	lb.in.
a		–	–	5x9,81	m/s ²
w		–	–	325	g

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Twelve devices are supplied in one SEMIBOX D without mounting hardware, which can be ordered separately under Ident No. 33321100 (for 10 SEMITRANS 3)

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